

**Quality Assurance** 4401 S. Beltwood Parkway Dallas, Texas 75244 PCN # E030101

DATE: <u>6/05/03</u>

## PRODUCT CHANGE NOTICE FORM

DALLAS SEMICONDUCTOR/MAXIM HEREBY ISSUES NOTIFICATION OF CHANGE THAT MAY AFFECT THE FOLLOWING CATEGORIES:

			, L				571120011120	•	
□ DESIGN	□ WAI	FER FAB		ASSE	MBLY		TEST	$\boxtimes$	ELEC/MECH SPECS
			Α	FFECT	ED PROD	UCT:			
		DALLAS I	P/N: D:	S1620					
DALLAS P/N:									
DALL			ALLAS P/N:						
		DALLAS F	P/N:						
CHANGE FROM:				c	CHANGE T	<b>O</b> :			
DS1620 current die	1620 current die revision D1.			DS1620 die revision E2.					
				h		or sof	ers should no tware in their		ve to change gns as a result of this
JUSTIFICATION: The new revision will be p			S C A S	The D1 revision implemented a proprietary temperatur sensing architecture, and E2 is converted to a commonly used bandgap reference with sigma-delta ADC. As a result of the architectural change, there are some changes to the electrical specifications between D1 and E2, highlighted in the table attached to this PCN.					
JUSTIFICATION: The process is qualified, a function and reliability	and the new	revision ha	s reacl	hed qua					
week of manufacture)	). This mar	king clearly	identi	ifies the	die revision	on to tl	he customer. I	<u>Dallas</u>	w are the year and work- Semiconductor product shipping label.
Dallas Semiconductor/M	laxim's Cha	nge Notificati	on Syst	tem is de	esigned to k	een ou	r customer base	e appri	sed of major product.

Dallas Semiconductor/Maxim's Change Notification System is designed to keep our customer base apprised of major product, manufacturing, or facility improvements. Since these changes may affect form, fit, function, quality, or reliability, it is the customer's right to request in writing of Dallas Semiconductor/Maxim's Quality Assurance Director that alternative action be taken.

Philip A. Adams, Quality Assurance Director

For further Information, please contact either of the people listed below.

Amy Gebrian, Business Manager Ken Wendel, Reliability Manager

(972) 371-6240/ email: amy.gebrian@dalsemi.com (972) 371-3726 / email: ken.wendel@dalsemi.com

Dallas Semiconductor/Maxim Rev A: 12/1/02 Owner: Quality Engineering

(-55°C to +125°C and 2.7V≤VDD≤5.5V unless otherwise noted)

Parameter	Conditions	DS1620E2 max	DS1620D1 max	Units
Thermometer Error	$0^{\circ}$ C to $+70^{\circ}$ C	±0.5	±0.5	°C
	$3.0V \le V_{DD} \le 5.5V$			
	0°C to +70°C	±1.25	±0.5	
	$2.7V \le V_{DD} < 3.0V$			
	-55°C to +125°C	±2	See curve in	
			DS1620 datasheet	
Temperature	9-bit Direct output with	750	1000	ms
Conversion Time	ability to calculate higher			
	resolution			
Thermometer		12	Unspecified	
Resolution				
Thermal Drift		±0.2	Unspecified	$^{\circ}\mathrm{C}$
Standby Supply	0°C to +70°C	1.5	1.0	μA
Current				•
NV (EEPROM) Write		10	50	ms
Cycle Time				
EEPROM Writes	-55°C to +55°C	50,000	Unspecified	Writes
Data Retention	-55°C to +55°C	10	Unspecified	Years
High Level Input		$Min=0.7xV_{DD}$	Min=2.0	V
Voltage				
Low-Level Input		Min=-0.5	Min=-0.3	V
Voltage		$Max=0.3xV_{DD}$	Max=+0.6	V
Absolute Maximum		+6.0	+7.0	V
Voltage on any Pin,				
Relative to Ground				
Clock to Data Delay		150	100	ns
Input Current on Each	$0.4 < V_{I/O} < 0.9 x V_{DD}$	±10	Unspecified	μΑ
Pin				•

The DS1620 datasheet will be modified upon the effective date of this PCN with the specifications *bold and italics* in the above table. The remaining datasheet specification changes specific to revision E2 will be reflected in the DS1620 datasheet once all revision D1 inventory has been shipped from Dallas Semiconductor.

Owner: Quality Engineering